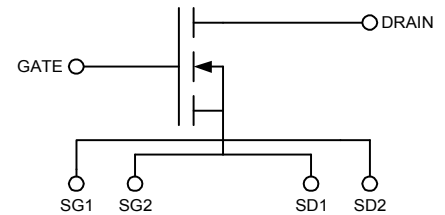


N-Channel Enhancement Mode
 Low Q_g and R_g
 High dv/dt
 Nanosecond Switching

$V_{DSS} = 100 \text{ V}$
 $I_{D25} = 30.0 \text{ A}$
 $R_{DS(on)} \leq 0.06 \Omega$
 $P_{DC} = 550 \text{ W}$

Symbol	Test Conditions	Maximum Ratings	
V_{DSS}	$T_J = 25^\circ\text{C}$ to 150°C	100	V
V_{DGR}	$T_J = 25^\circ\text{C}$ to 150°C ; $R_{GS} = 1 \text{ M}\Omega$	100	V
V_{GS}	Continuous	± 20	V
V_{GSM}	Transient	± 30	V
I_{D25}	$T_c = 25^\circ\text{C}$	30.0	A
I_{DM}	$T_c = 25^\circ\text{C}$, pulse width limited by T_{JM}	240	A
I_{AR}	$T_c = 25^\circ\text{C}$	TBD	A
E_{AR}	$T_c = 25^\circ\text{C}$	TBD	mJ
dv/dt	$I_S \leq I_{DM}$, $di/dt \leq 100 \text{ A}/\mu\text{s}$, $V_{DD} \leq V_{DSS}$, $T_J \leq 150^\circ\text{C}$, $R_G = 0.2 \Omega$	5.5	V/ns
	$I_S = 0$	>200	V/ns
P_{DC}		550	W
P_{DHS}	$T_c = 25^\circ\text{C}$ Derate $4.4 \text{ W}/^\circ\text{C}$ above 25°C	270	W
P_{DAMB}	$T_c = 25^\circ\text{C}$	3.5	W
R_{thJC}		0.25	C/W
R_{thJHS}		0.53	C/W



Symbol	Test Conditions	Characteristic Values			
		$T_J = 25^\circ\text{C}$ unless otherwise specified			
		min.	typ.	max.	
V_{DSS}	$V_{GS} = 0 \text{ V}$, $I_D = 3 \text{ ma}$			100	V
$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{a}$	2	2.5	4	V
I_{GSS}	$V_{GS} = \pm 20 \text{ V}_{DC}$, $V_{DS} = 0$			± 100	nA
I_{DSS}	$V_{DS} = 0.8 V_{DSS}$, $T_J = 25^\circ\text{C}$ $V_{GS} = 0$, $T_J = 125^\circ\text{C}$			25	μA
				250	μA
$R_{DS(on)}$	$V_{GS} = 15 \text{ V}$, $I_D = 0.5 I_{D25}$ Pulse test, $t \leq 300 \mu\text{s}$, duty cycle $d \leq 2\%$			0.06	Ω
g_{fs}	$V_{DS} = 15 \text{ V}$, $I_D = 0.5 I_{D25}$, pulse test		9.7		S
T_J		-55		+175	$^\circ\text{C}$
T_{JM}			175		$^\circ\text{C}$
T_{stg}		-55		+175	$^\circ\text{C}$
T_L	1.6mm(0.063 in) from case for 10 s		300		$^\circ\text{C}$
Weight			2		g

Features

- Isolated Substrate
 - high isolation voltage (>2500V)
 - excellent thermal transfer
 - Increased temperature and power cycling capability
- IXYS advanced low Q_g process
- Low gate charge and capacitances
 - easier to drive
 - faster switching
- Low $R_{DS(on)}$
- Very low insertion inductance (<2nH)
- No beryllium oxide (BeO) or other hazardous materials

Advantages

- Optimized for RF and high speed switching
- Easy to mount—no insulators needed
- High power density



DE275-101N30A RF Power MOSFET

Symbol	Test Conditions	Characteristic Values ($T_J = 25^\circ\text{C}$ unless otherwise specified)		
		min.	typ.	max.
R_G				5 Ω
C_{iss}			2500	pF
C_{oss}	$V_{GS} = 0\text{ V}$, $V_{DS} = 0.8 V_{DSS(max)}$, $f = 1\text{ MHz}$		700	pF
C_{rss}			145	pF
C_{stray}	Back Metal to any Pin		16	pF
$T_{d(on)}$			5	ns
T_{on}	$V_{GS} = 15\text{ V}$, $V_{DS} = 0.8 V_{DSS}$ $I_D = 0.5 I_{DM}$		5	ns
$T_{d(off)}$	$R_G = 0.2\ \Omega$ (External)		8	ns
T_{off}			8	ns
$Q_{g(on)}$			94	nC
Q_{gs}	$V_{GS} = 10\text{ V}$, $V_{DS} = 0.5 V_{DSS}$ $I_D = 0.5 I_{D25}$		11	nC
Q_{gd}			42	nC

Source-Drain Diode

Characteristic Values

($T_J = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Test Conditions	min.	typ.	max.
I_S	$V_{GS} = 0\text{ V}$			30.0 A
I_{SM}	Repetitive; pulse width limited by T_{JM}			240 A
V_{SD}	$I_F = I_S$, $V_{GS} = 0\text{ V}$, Pulse test, $t \leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$			2.5 V
T_{rr}			600	ns

CAUTION: Operation at or above the Maximum Ratings values may impact device reliability or cause permanent damage to the device.

Information in this document is believed to be accurate and reliable. IXYSRF reserves the right to make changes to information published in this document at any time and without notice.

For detailed device mounting and installation instructions, see the “*Device Installation & Mounting Instructions*” technical note on the IXYSRF web site at;

http://www.ixysrf.com/pdf/switch_mode/appnotes/7de_series_mosfet_installation_instructions.pdf

IXYS RF reserves the right to change limits, test conditions and dimensions.

IXYS RF MOSFETS are covered by one or more of the following U.S. patents:

4,835,592	4,860,072	4,881,106	4,891,686	4,931,844	5,017,508
5,034,796	5,049,961	5,063,307	5,187,117	5,237,481	5,486,715
5,381,025	5,640,045				

Fig. 1

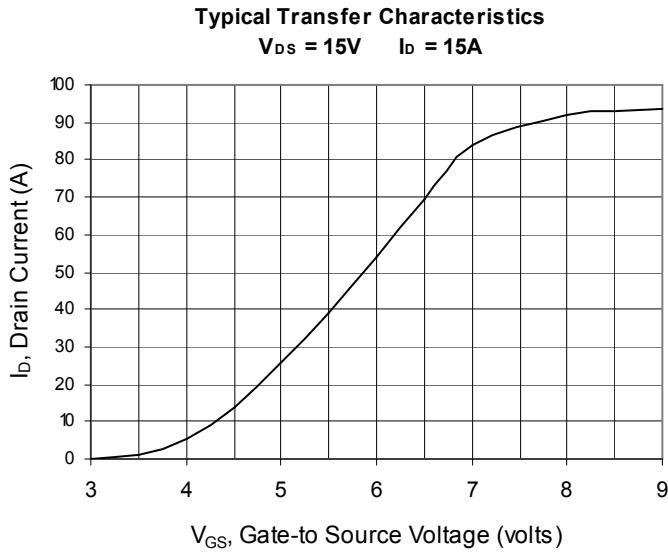


Fig. 2

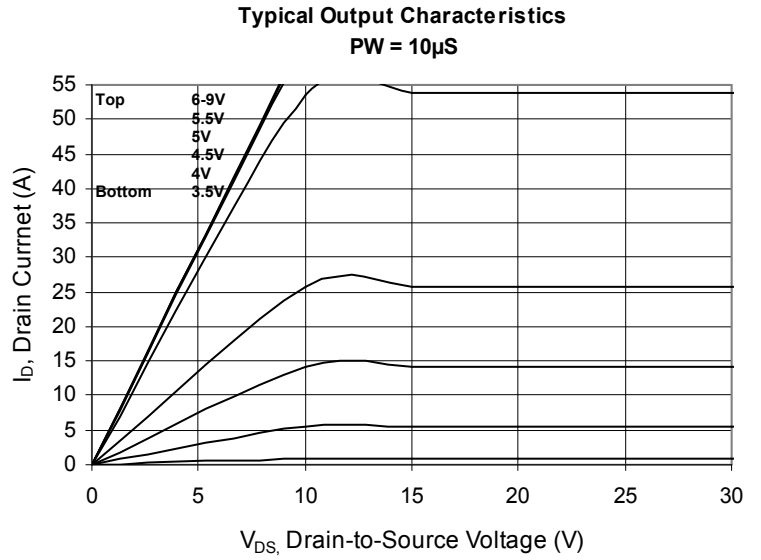


Fig. 3

Gate Charge vs. Gate-to-Source Voltage
 $V_{DS} = 50V$ $I_D = 15A$

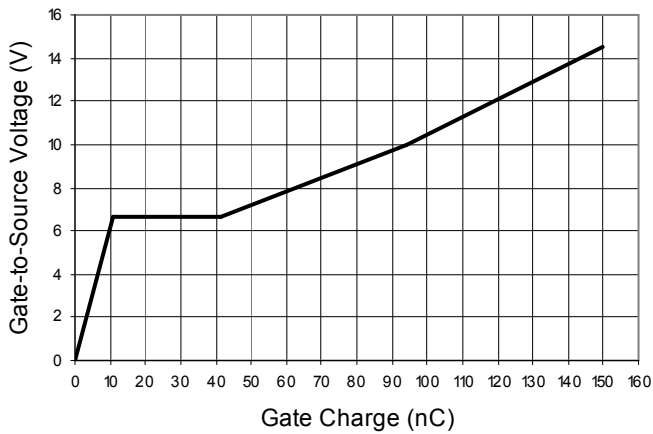


Fig. 4

Extended Typical Output Characteristics

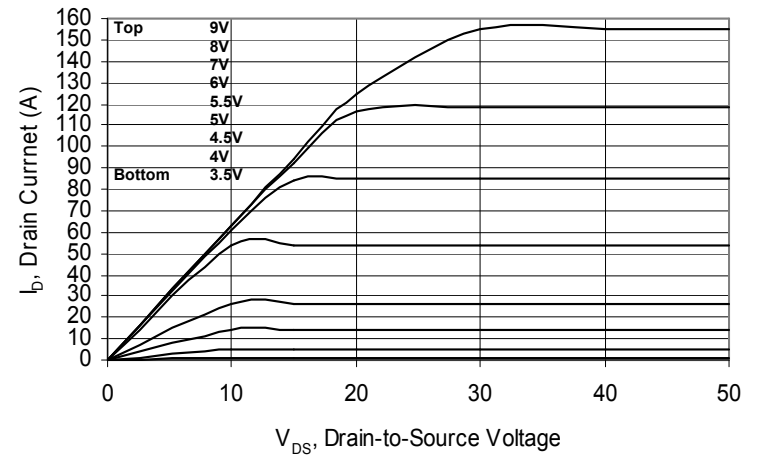


Fig. 5

V_{DS} vs. Capacitance

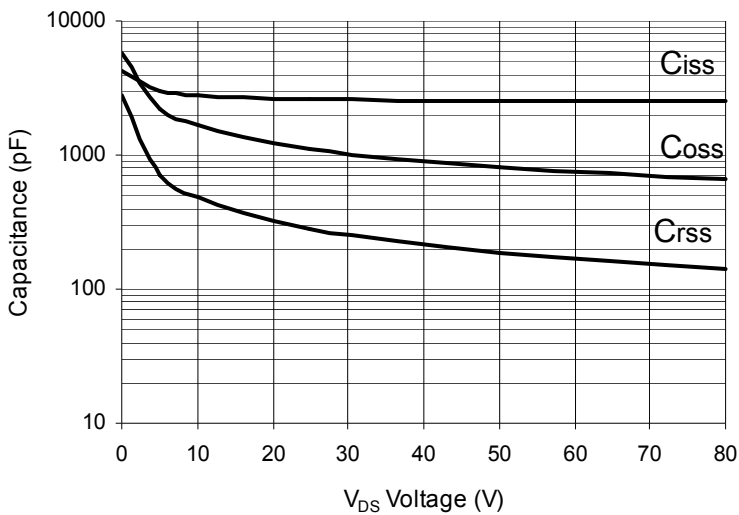
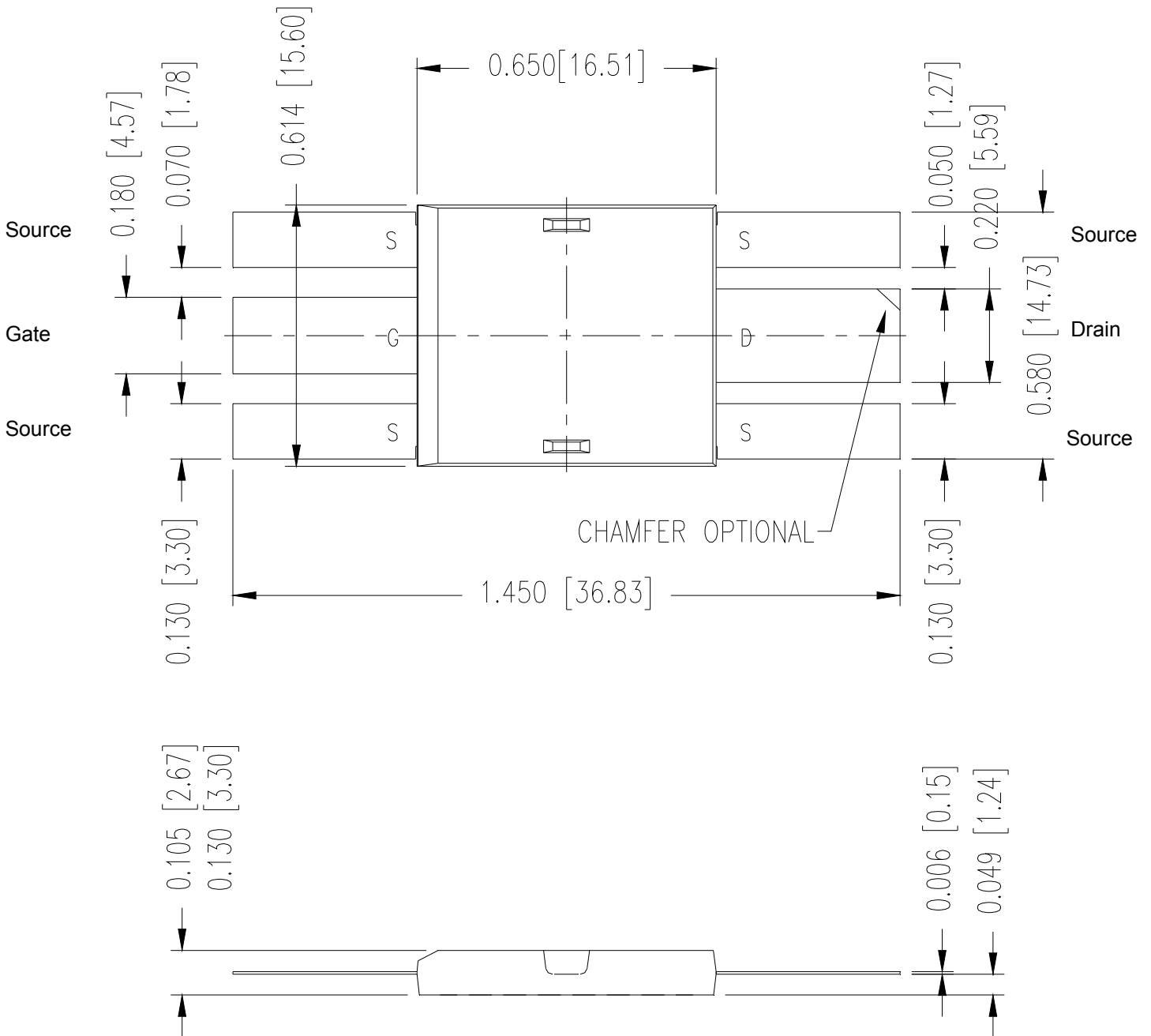


Fig. 6 Package Drawing



101N30A DE-SERIES SPICE Model

The DE-SERIES SPICE Model is illustrated in Figure 7. The model is an expansion of the SPICE level 3 MOSFET model. It includes the stray inductive terms L_G , L_S and L_D . R_d is the $R_{DS(ON)}$ of the device, R_{ds} is the resistive leakage term. The output capacitance, C_{OSS} , and reverse transfer capacitance, C_{RSS} are modeled with reversed biased diodes. This provides a varactor type response necessary for a high power device model. The turn on delay and the turn off delay are adjusted via R_{on} and R_{off} .

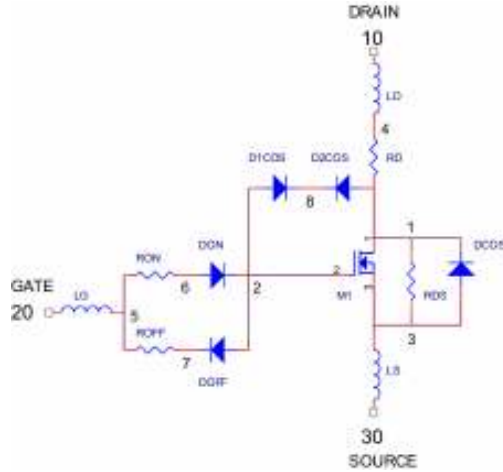


Figure 7 DE-SERIES SPICE Model

This SPICE model may be downloaded as a text file from the IXYSRF web site at
http://www.ixysrf.com/products/switch_mode.html
<http://www.ixysrf.com/spice/de275-101n30a.html>

```
*SYM=POWMOSN
.SUBCKT 101N09A 10 20 30
* TERMINALS: D G S
* 100 Volt 30 Amp .05 ohm N-Channel Power MOSFET 10-30-2001
M1 1 2 3 3 DMOS L=1U W=1U
RON 5 6 1.5
DON 6 2 D1
ROF 5 7 .2
DOF 2 7 D1
D1CRS 2 8 D2
D2CRS 1 8 D2
CGS 2 3 2.5N
RD 4 1 .05
DCOS 3 1 D3
RDS 1 3 5.0MEG
LS 3 30 .1N
LD 10 4 1N
LG 20 5 1N
.MODEL DMOS NMOS (LEVEL=3 VTO=3.0 KP=9.0)
.MODEL D1 D (IS=.5F CJO=1P BV=100 M=.5 VJ=.6 TT=1N)
.MODEL D2 D (IS=.5F CJO=1100P BV=100 M=.5 VJ=.6 TT=1N RS=10M)
.MODEL D3 D (IS=.5F CJO=300P BV=100 M=.3 VJ=.4 TT=400N RS=10M)
.ENDS
```

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